Search Notes

,	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/079,873	TANAKA ET AL.	TANAKA ET AL.
	Examiner	Art Unit	Art Unit
	Cynthia Lee	1745	1745

SEARCHED					
Class	Subclass	Date	Examiner		
429	33	1/3/2006	CL		

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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

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